

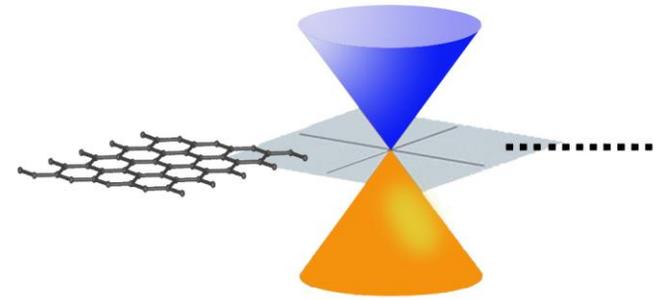
Single-shot readout in graphene quantum dots

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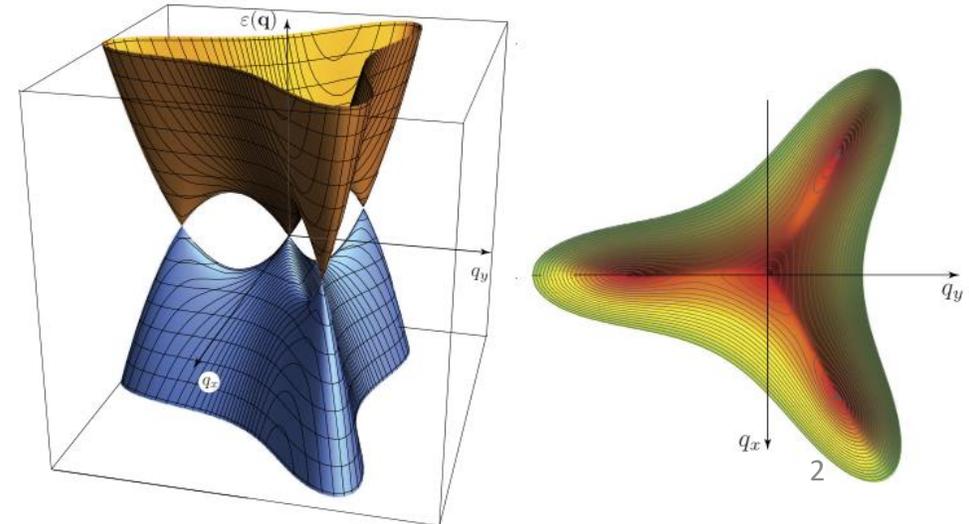
Why Graphene?

- Low nuclear Spin concentration: $^{12}\text{C} \sim 98.9\%$: $s = 0$; $^{13}\text{C} \sim 1.1\%$: $s = \frac{1}{2}$
- Weak SOI: similar strength as in Si
- Strong 2D confinement:
 - Smaller devices (But harder fab...)
 - Stronger coupling to gates etc.

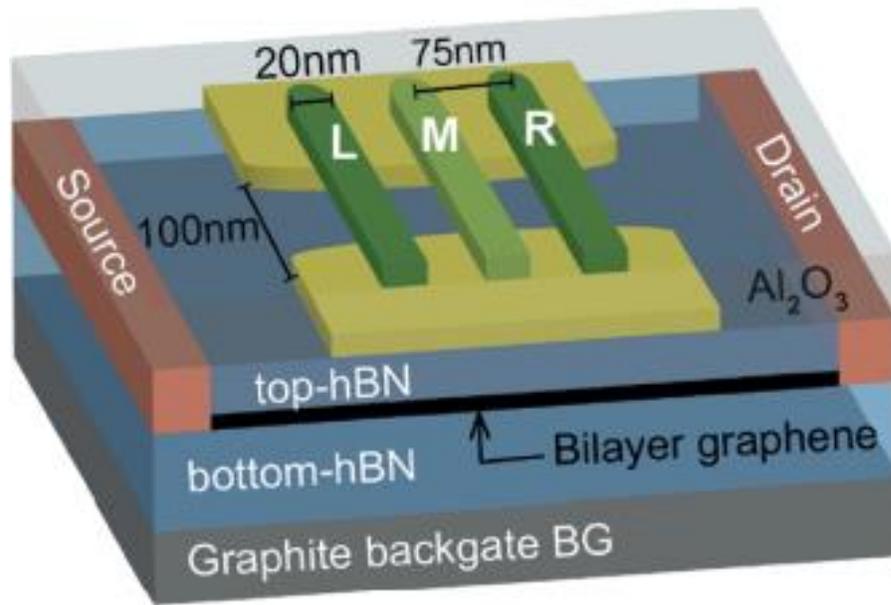


Bilayer Graphene:

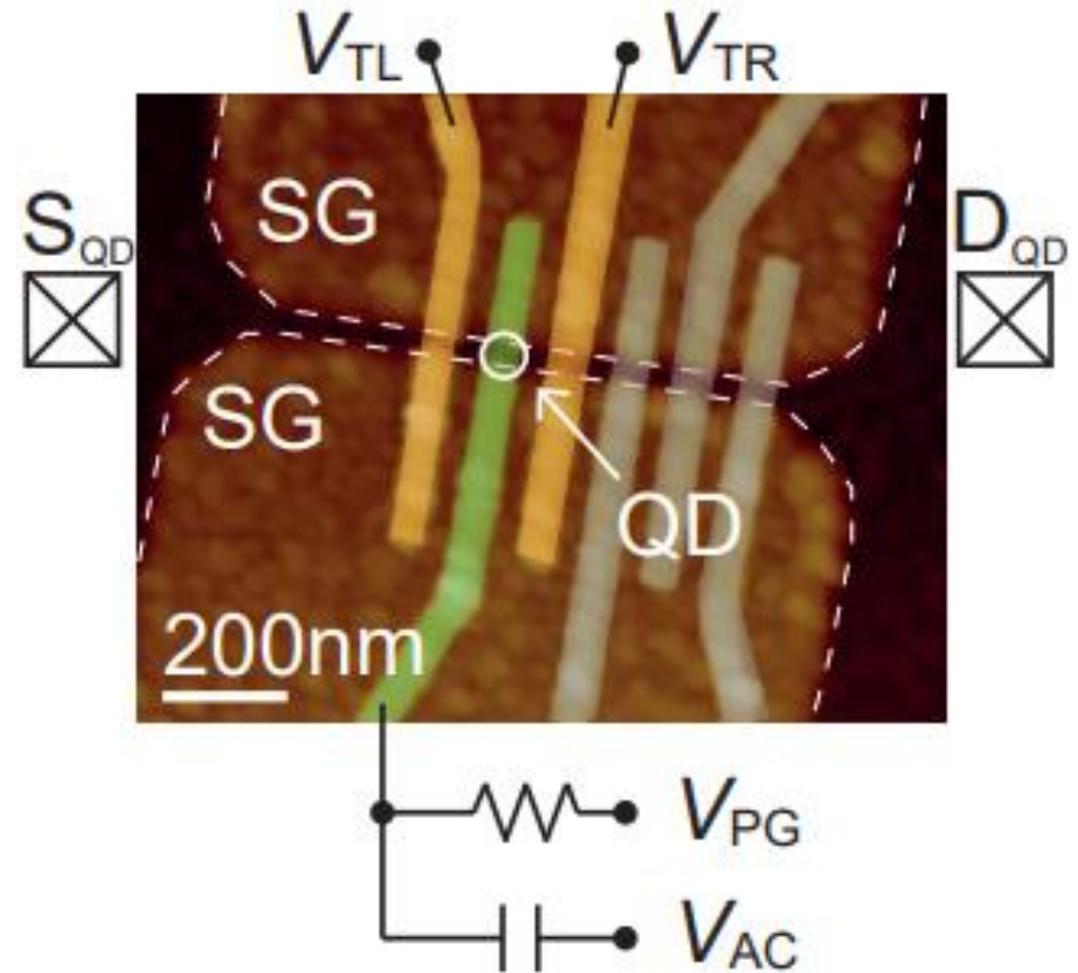
- 4 Atoms in unit cell, 2 directly on top of each other
 - Strongly coupled “dimer sites” due to p_z -orbital overlap
- Band Structure evolution:
 - Single Layer Graphene: Dirac cones, linear dispersion
 - Bilayer: Parabolic dispersion near Dirac points
 - Bilayer: “Weak trigonal wrapping”
 - **Band Gap opens in external electric field!**
 - **In general: 2 degenerate valleys!**



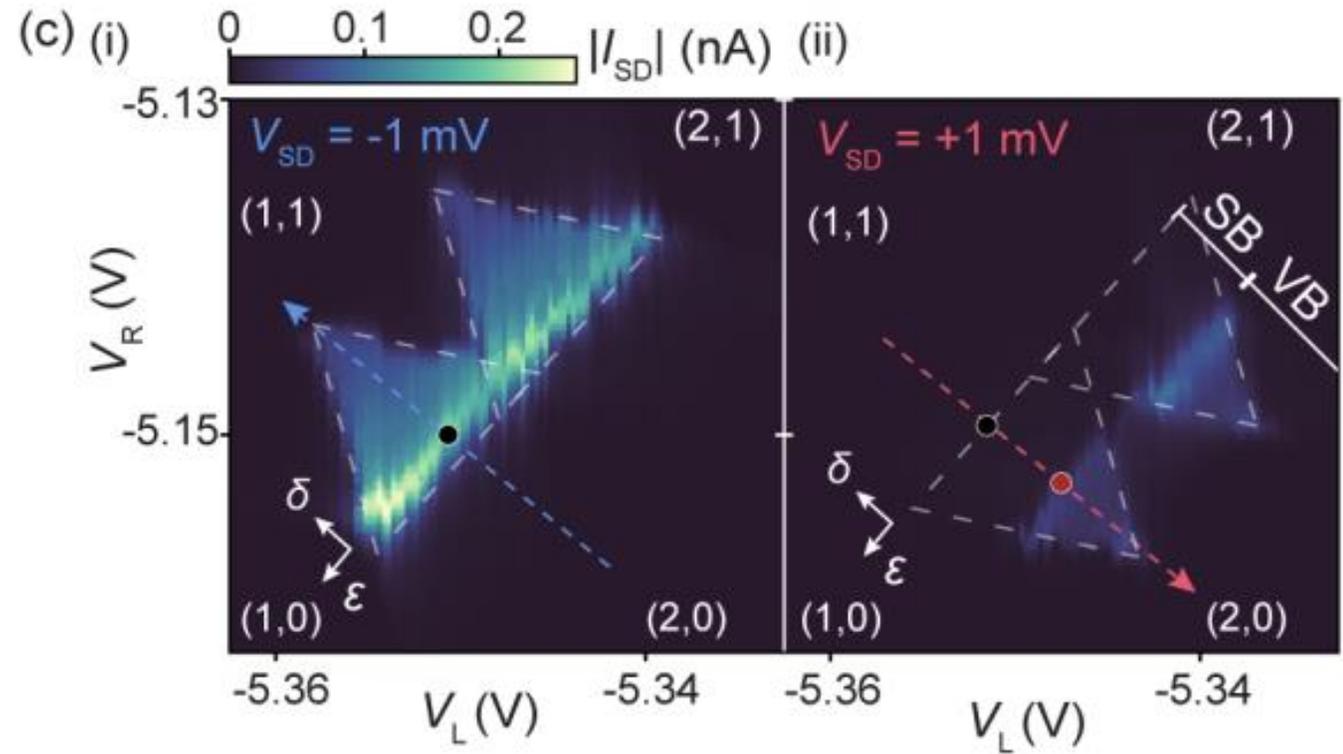
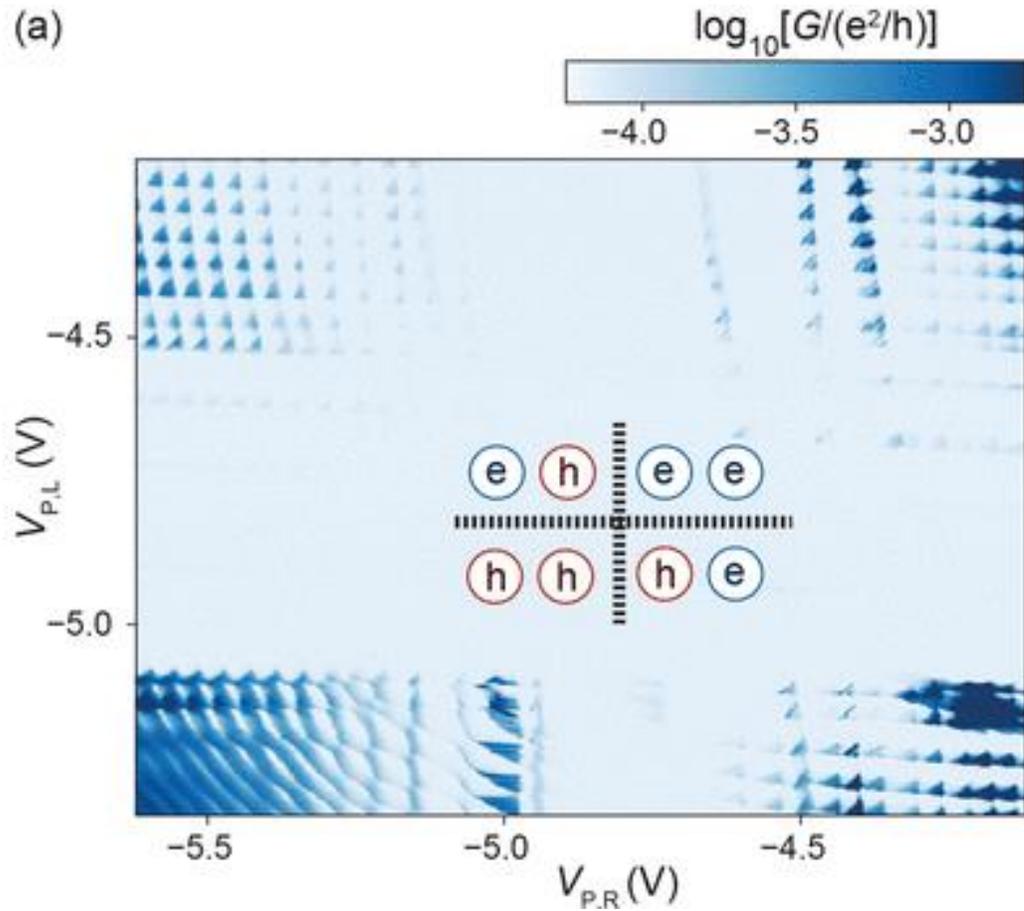
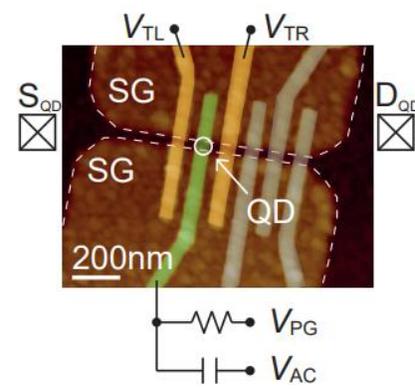
The Device (Pt. 1)



- Bilayer Graphene encapsulated in two hBN layers
- Graphite Backgate
- Two top gate layers:
 - Split gate for channel formation
 - Finger gates
 - Separated by 20 nm ALD Al₃O₂



Previous Results

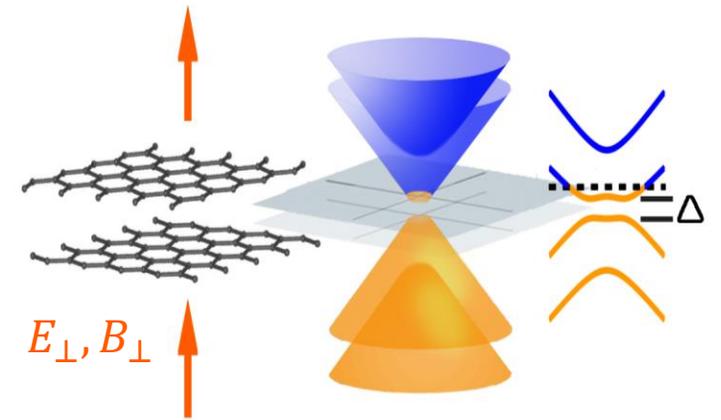
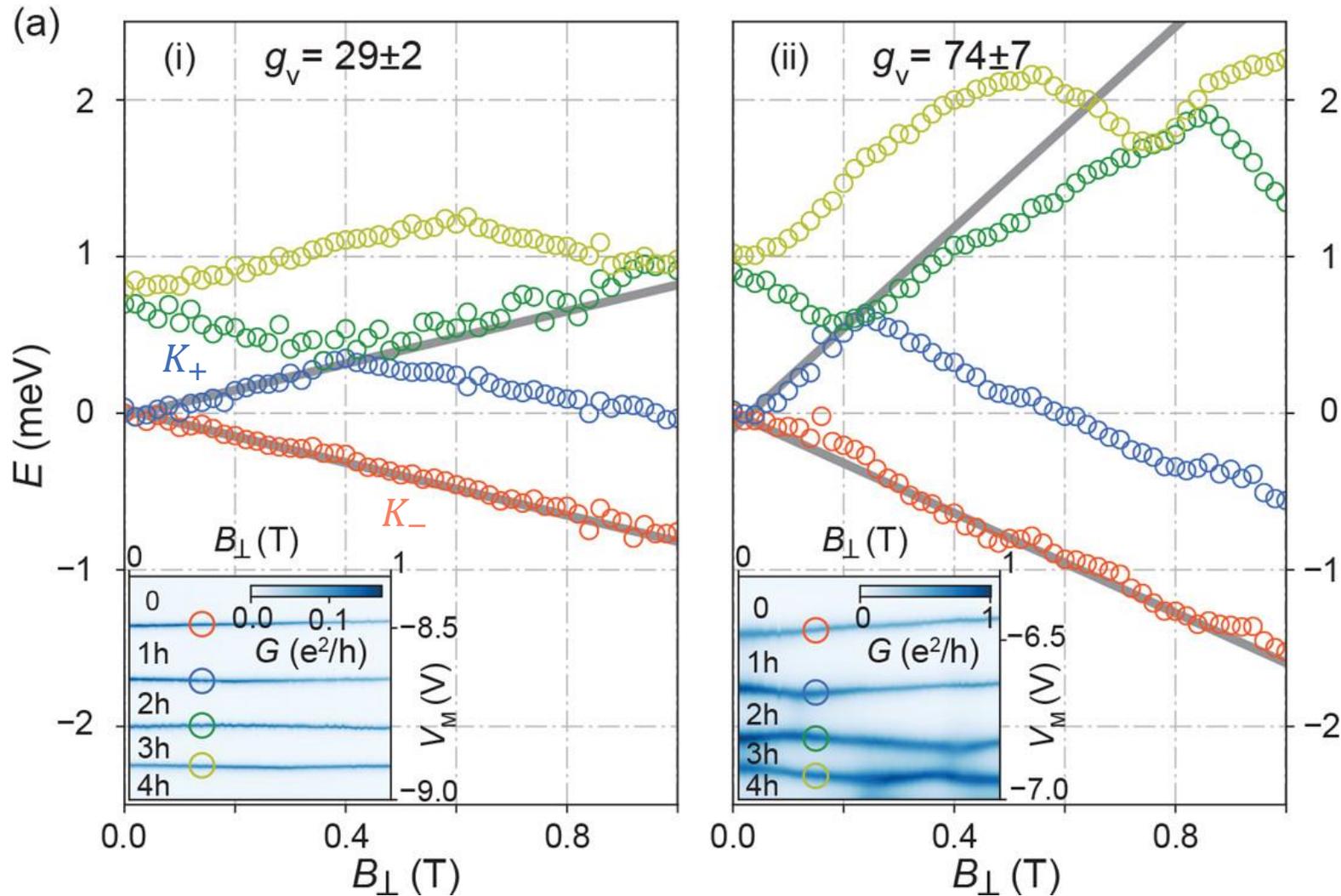


H. Overweg *et al. Nano Lett.* **18** (2018)

C. Tong *et al. Nano Lett.* **21** (2021)

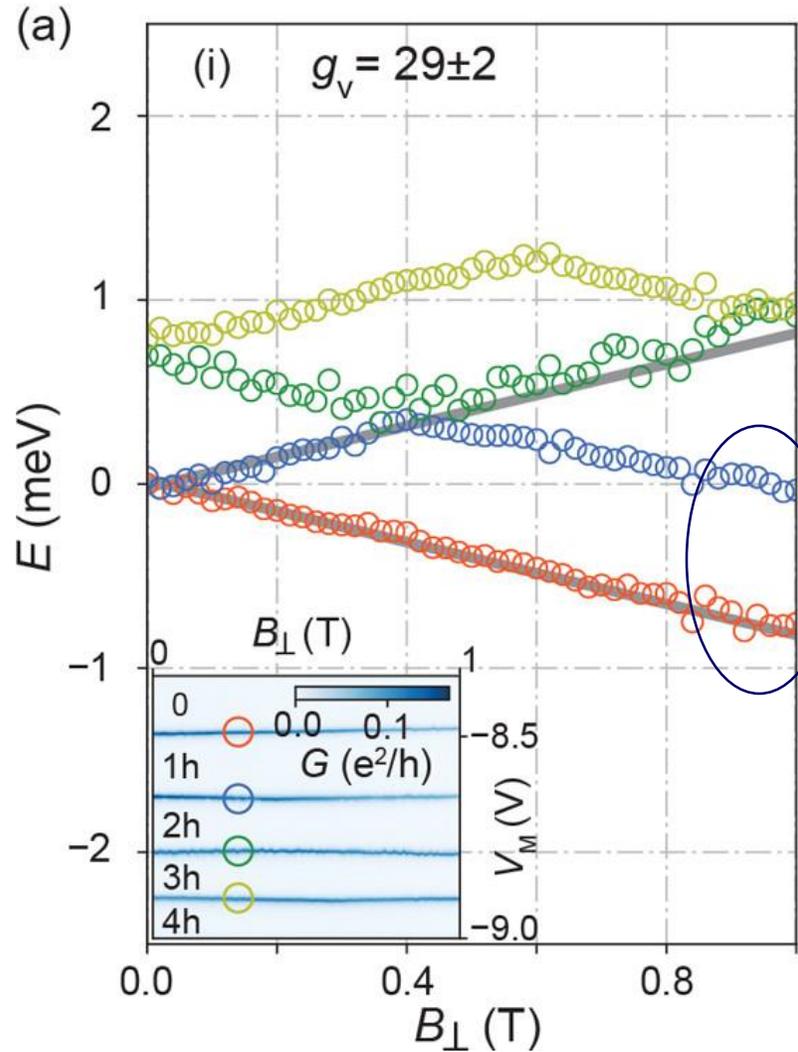
C. Tong *et al. arXiv:2106.04722v2*

Valley-Splitting and Valley-g-Factor

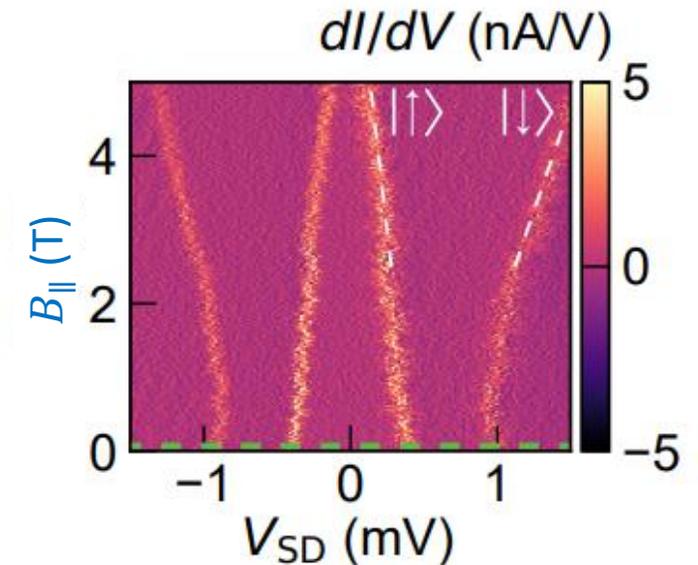
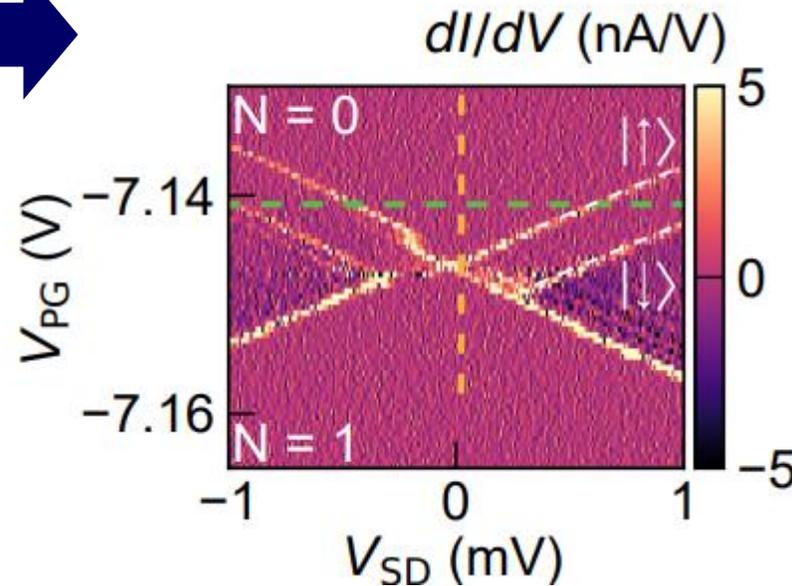


- Operation as a hole-SQD
- Ground state splits in perpendicular magnetic field B_{\perp}
- Valley-g-Factor $g_v = \frac{\Delta E_{K^+,K^-}}{\mu_B B_{\perp}}$
- Strong tunability of valley-g Factor through dot size

Creating an effective Two-Level-System

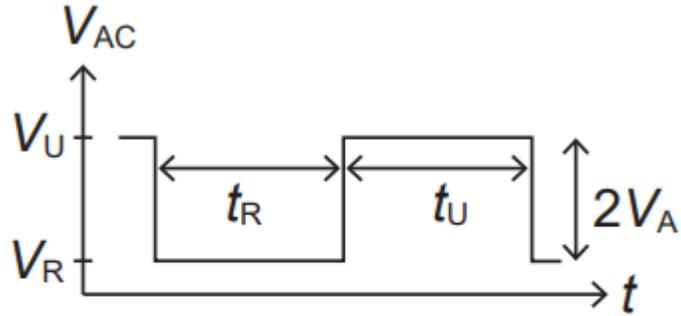


- Operation as a hole-SQD at 9 mK
- Valley-polarized ground $|K' \uparrow\rangle = |\uparrow\rangle$ & 1st excited $|K' \downarrow\rangle = |\downarrow\rangle$ state for $B_{\perp} = 1.75$ T
- Splitting as seen in coulomb diamond
- Additional in-plane B_{\parallel} **only couples to spin!**
- Observe $g_s = 2$ and $\Delta_{SO} = 60$ μeV



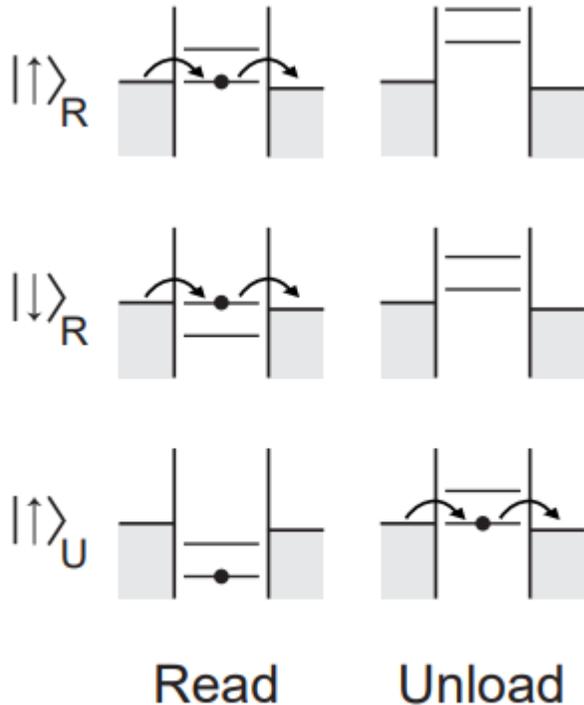
Pulsed Transient Current Spectroscopy

(b)



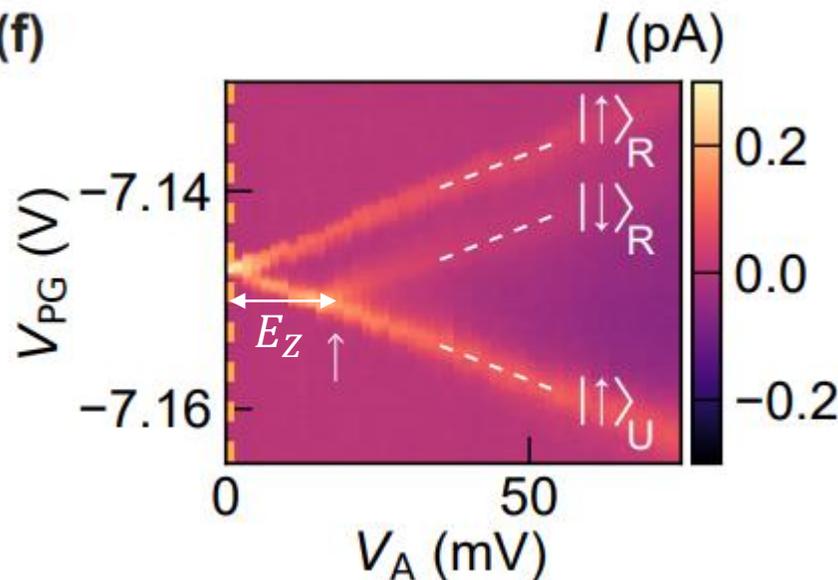
- Constant bias: $V_{SD} = 40\mu V$
- 2-Level pulse scheme on plunger
- Current observed either during read (R) or unload (U) phase:
 - Resonant tunnelling during R (excited state only at high B)
 - Relaxation during R blocks current, observed in U

(e)

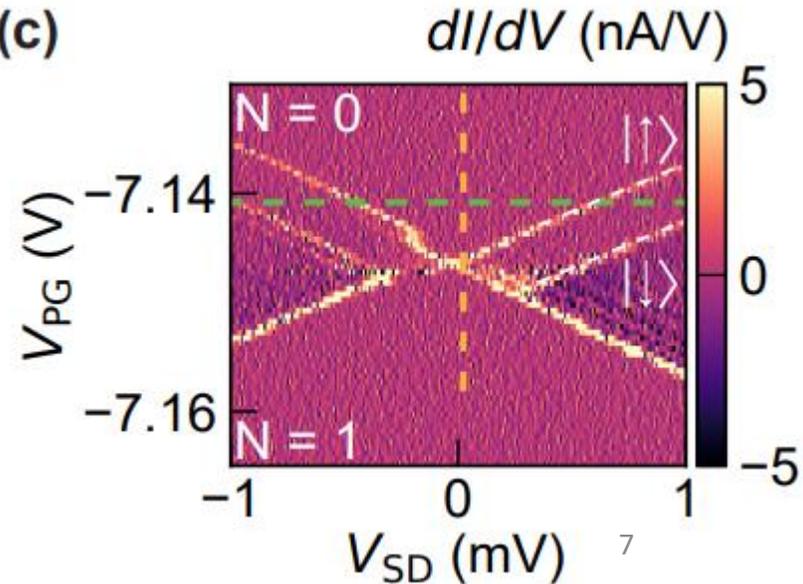


- Pulse amplitude lever arm: $\alpha_{att} = 0.21$ $\alpha_{PG} = 0.05$
- Allows conversion of Pulse amplitude to energy

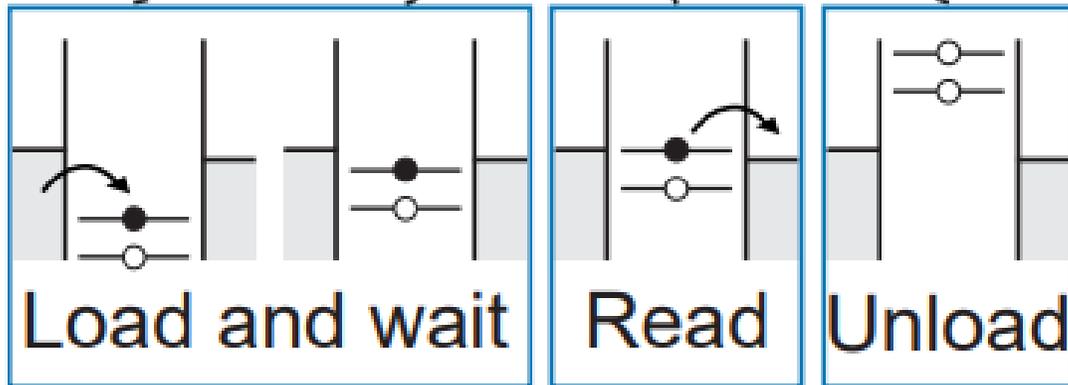
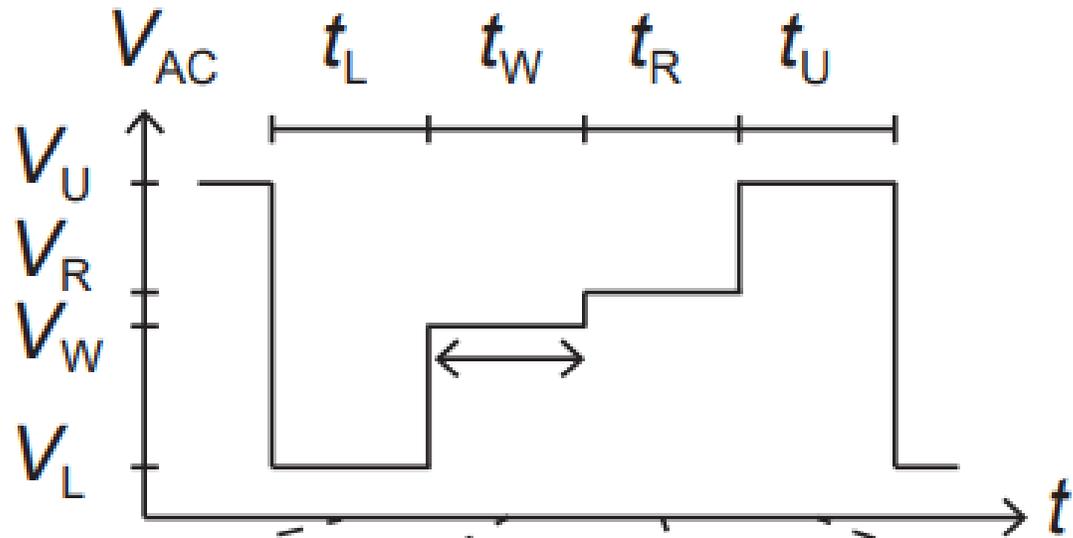
(f)



(c)

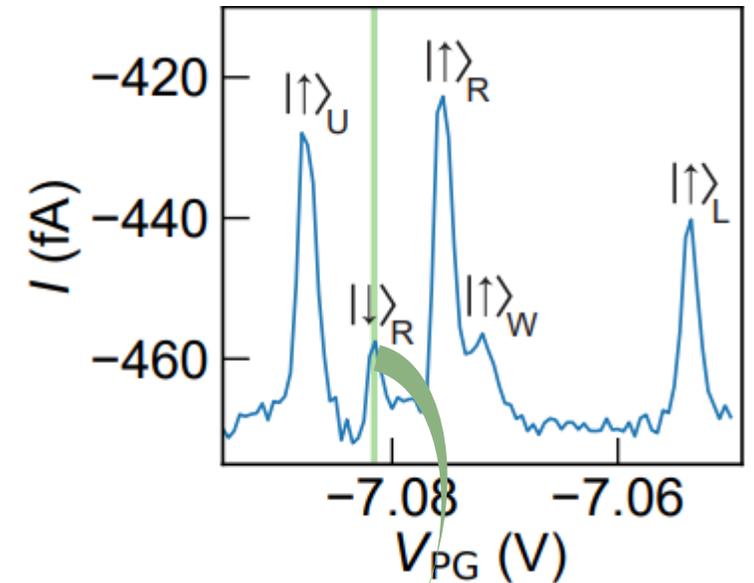


Measuring T_1

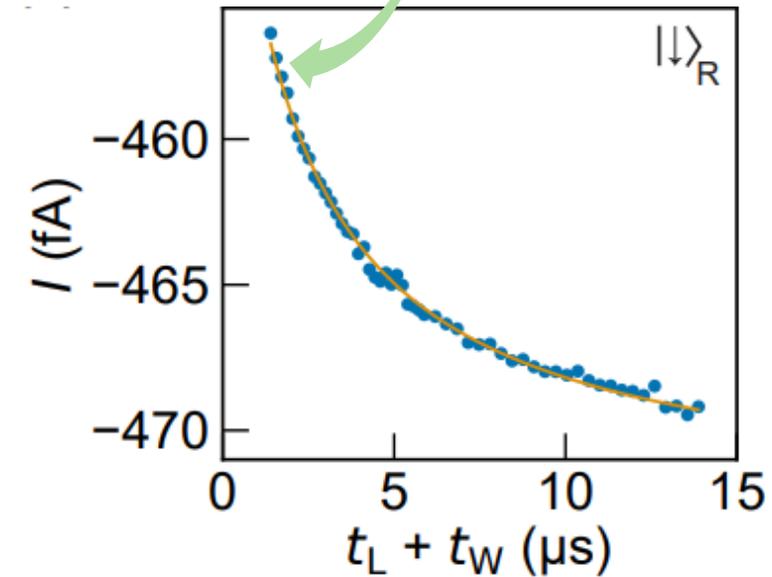


- Can be done through $I_{|\downarrow\rangle_R}(t_R)$ measurement
- But only gives lower bound!
- **Better 4-level pulse scheme**

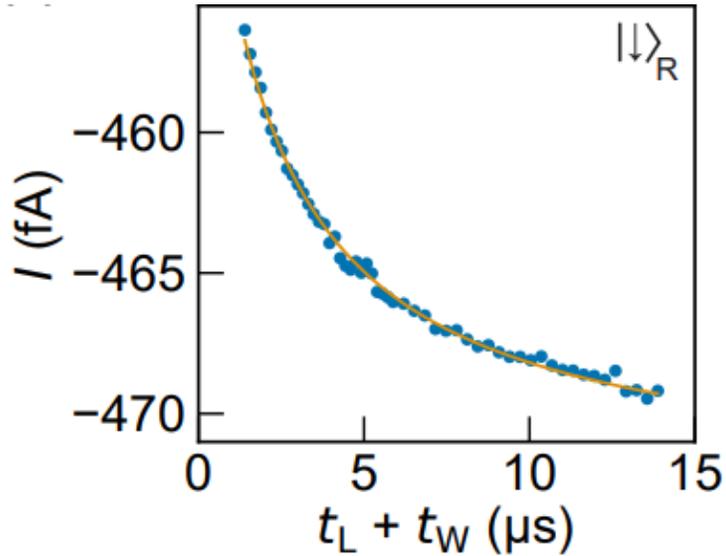
Time-integral of 4-level scheme kept at 0
Choosing correct peak in plunger trace



Increasing $\tau = t_L + t_W$ results in decay of observed current



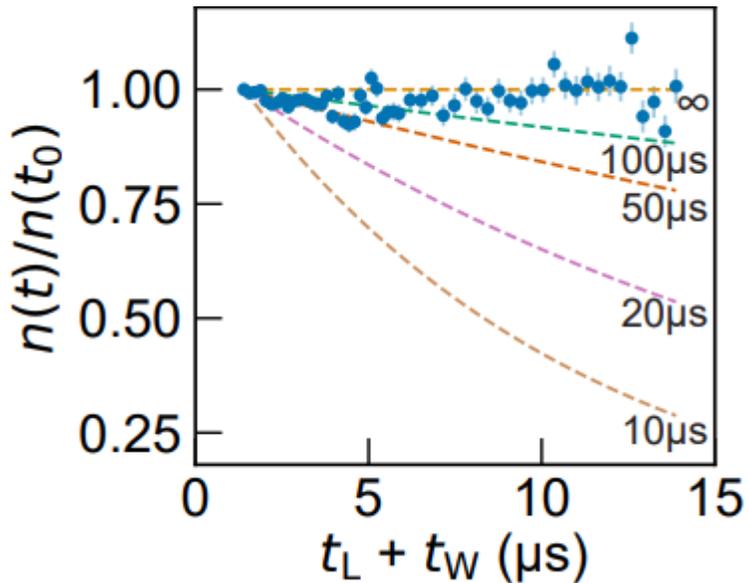
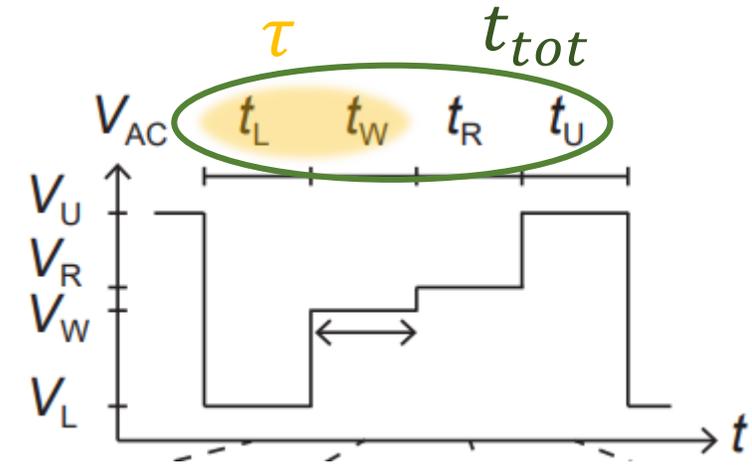
Measuring T_1



- Problem: long τ \rightarrow long t_{tot}

$$I = \langle n \rangle \frac{e^{-\tau/T_1}}{t_{tot}}$$

Carriers per pulse cycle

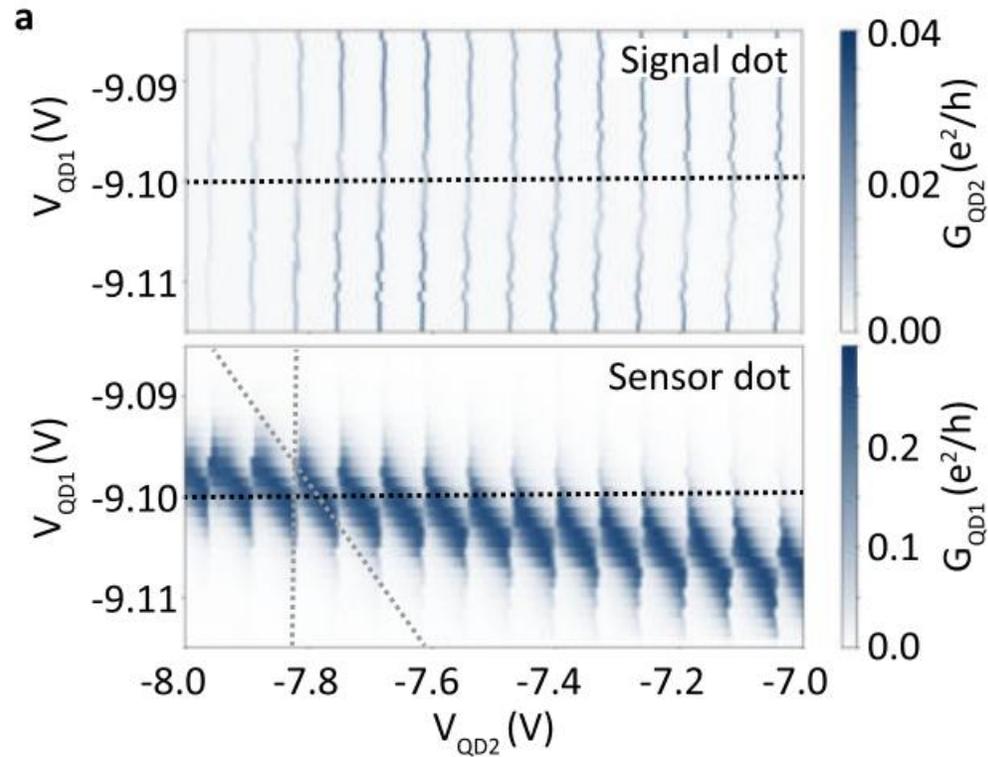


- Current decreases as pulse scheme gets longer!
- Limited by background noise on order 0.1 fA (!!)

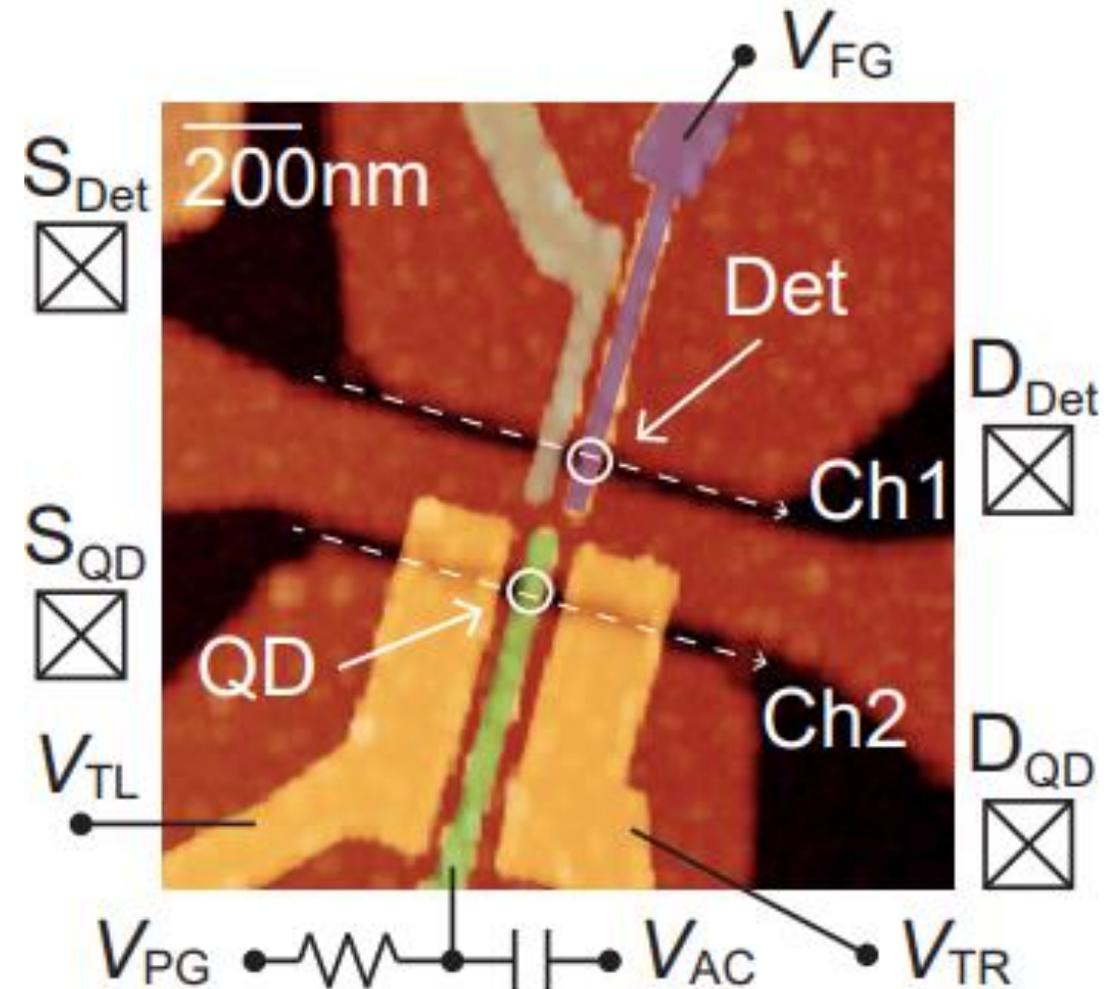
- Conservative estimate: $T_1 \geq 100 \mu s$

- **Need better readout!**

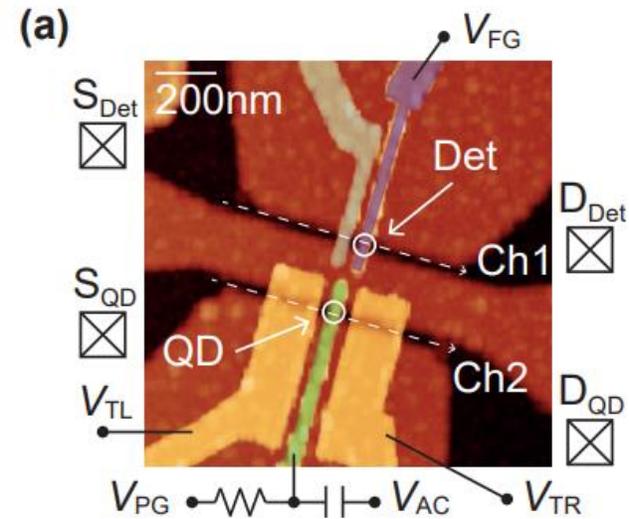
The Device (Pt. 2)



- Sensor dot next to target QD
- Separated by 150 nm wide depletion gate
- Much wider barrier gates than in device 1
- Charge sensing described in previous work

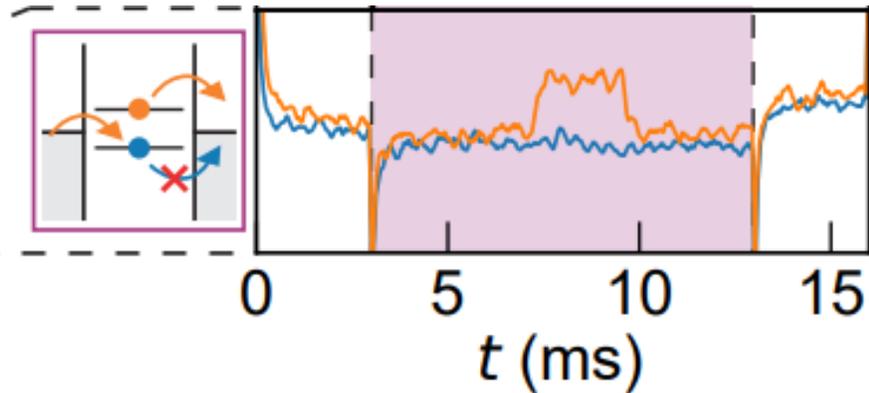


Single-Shot Readout (Pt.1)

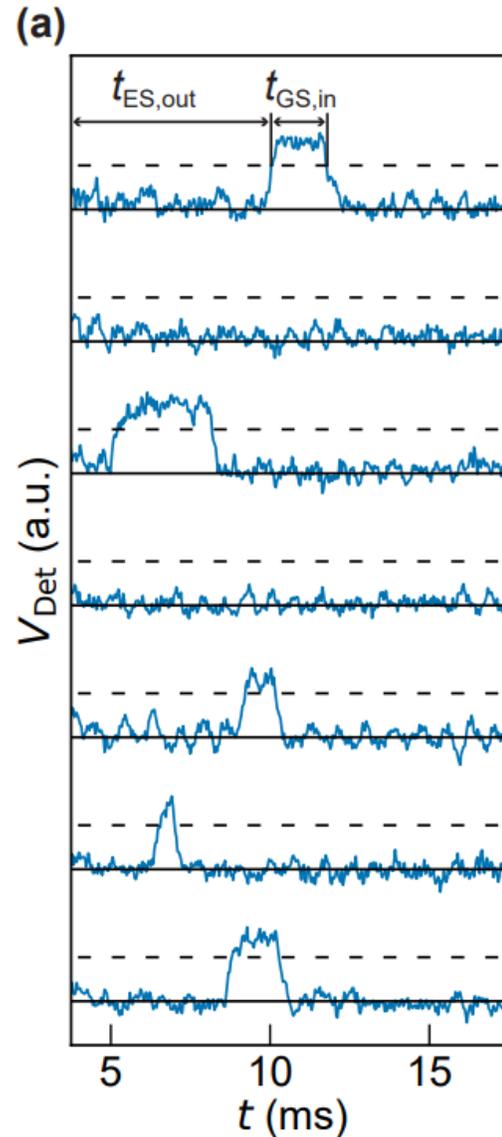


- Tune to valley-polarized spin-2LS:
 $B_{\perp} = 2 T$
- No need for in-plane B_{\parallel} (?)
- Elzerman-readout:
- Monitoring voltage across sensor
- 3 different plunger voltage regimes:
 - Single step: both levels above reservoir
 - Multiple blips: Sequential tunnelling to GS
 - Single blip/none: Good for “qubit”-readout

Single-Shot Readout (Pt.2)



- 10'000 single-shot traces:
- Extract tunnel times:
 - Unloading of excited state: $t_{ES,out}$
 - Reloading of ground state: $t_{GS,in}$
- Detector-Voltage histogram shows 2 peaks
- Fits to tunnel times yield:
 - $\tau_{ES,out} = 4,64 \text{ ms}$
 - $\tau_{GS,in} = 0,66 \text{ ms}$
- Readout fidelities & state visibility:
 - $F_{ES} = 90,1 \%$
 - $F_{GS} = 97 \%$ $V = 87.1 \%$



Conclusions

- Excited state lifetime in bilayer graphene
- $T_1 \sim ms$ Comparable to other electron spin qubit systems
- Single-shot readout realized using DC-sensor dot

Outlook:

- Improve readout speed using RF-sensor dot or dispersive sensing
- Readout of DQD system with spin/valley blockade
- Driving the qubit?